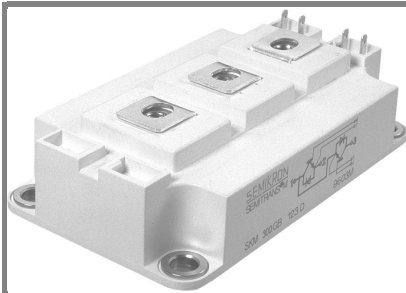


# SKM 150GB063D



**SEMITRANS™ 3**

## Superfast NPT-IGBT Modules

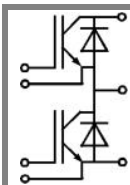
**SKM 150GB063D**

### Features

- N channel, Homogeneous Silicon structure (NPT - Non punch-through IGBT)
- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of  $V_{CEsat}$
- 50 % less turn off losses
- 30 % less short circuit current
- Very low  $C_{ies}$ ,  $C_{oes}$ ,  $C_{res}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
- Large clearance (13 mm) and creepage distances (20 mm)

### Typical Applications

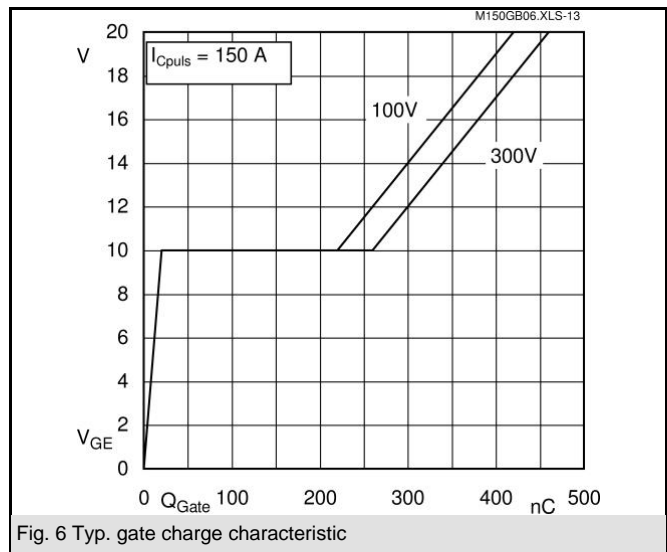
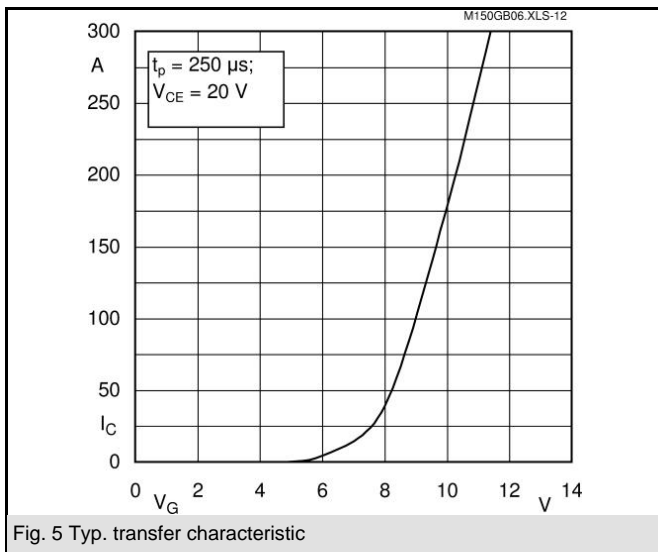
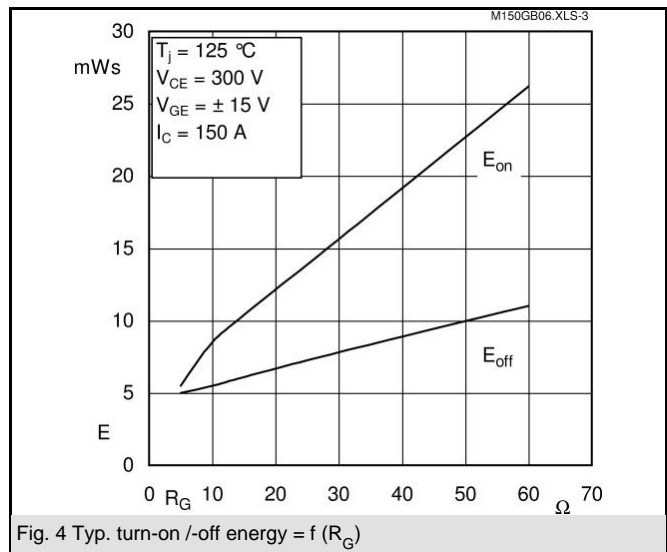
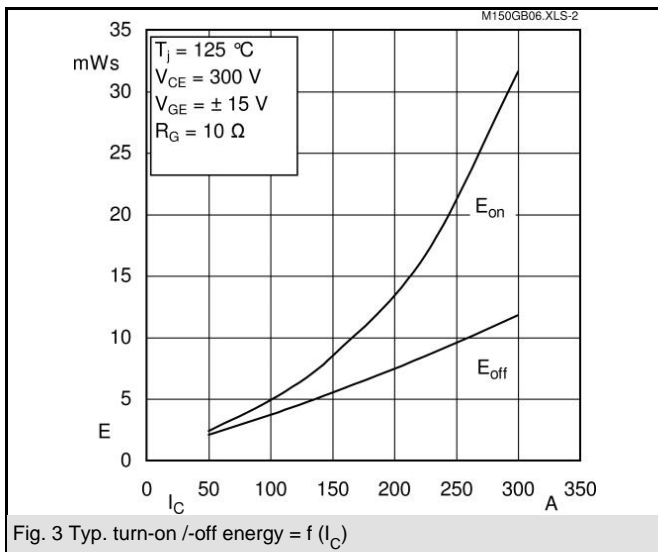
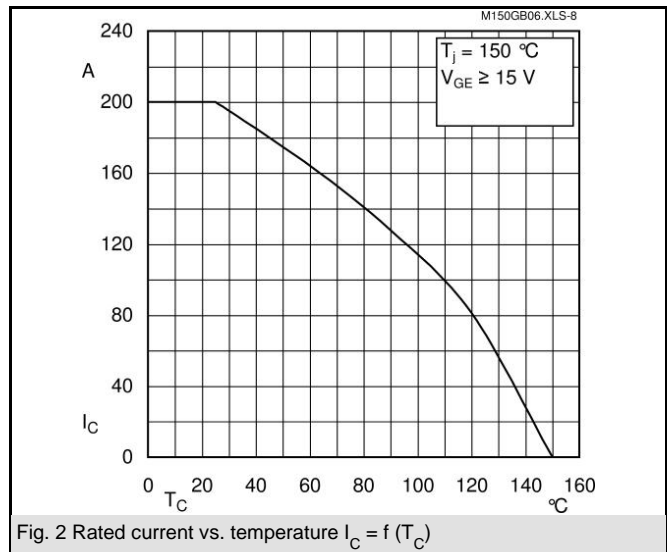
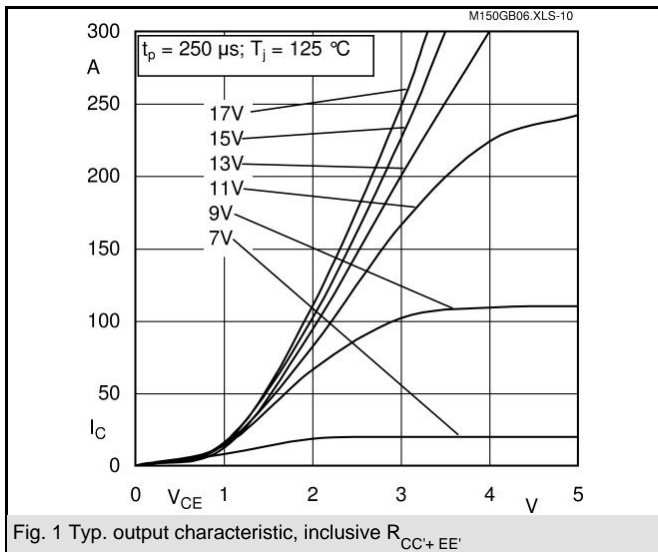
- Switching (not for linear use)
- Switched mode power supplies
- UPS
- AC inverter servo drives
- Pulse frequencies also above 10 kHz
- Welding inverters

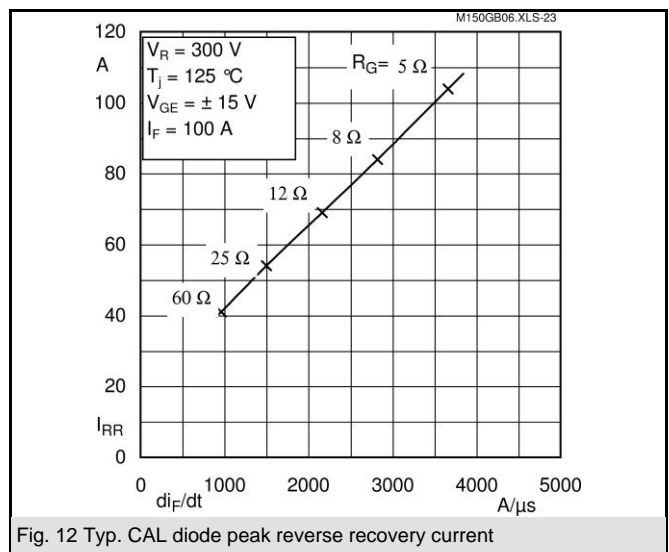
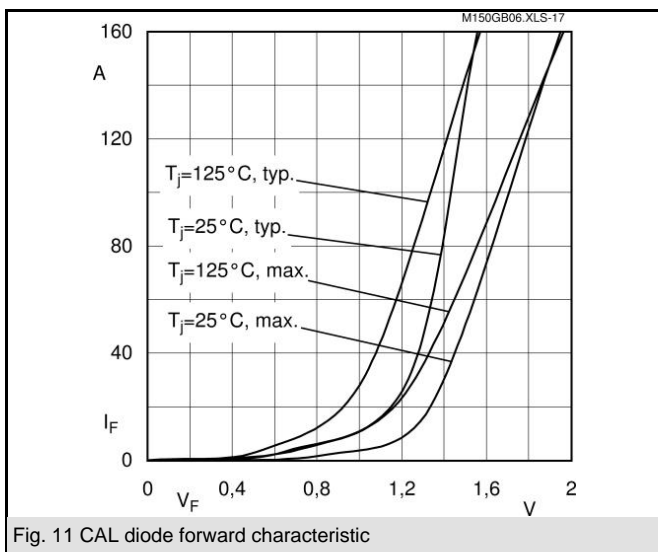
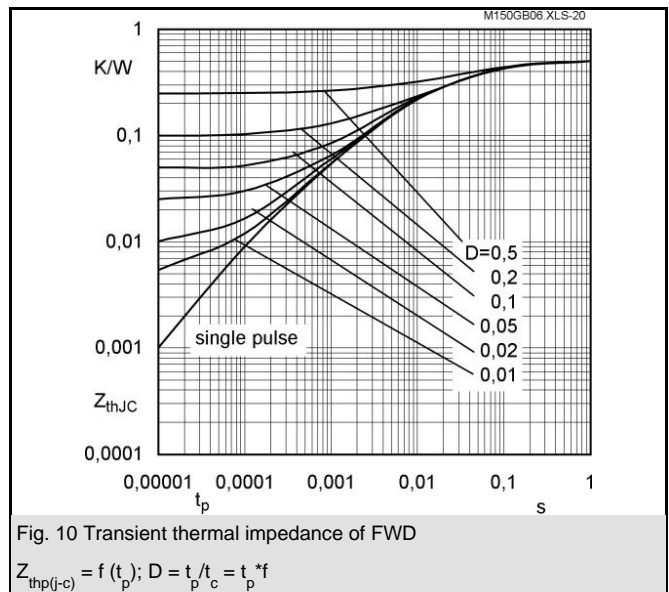
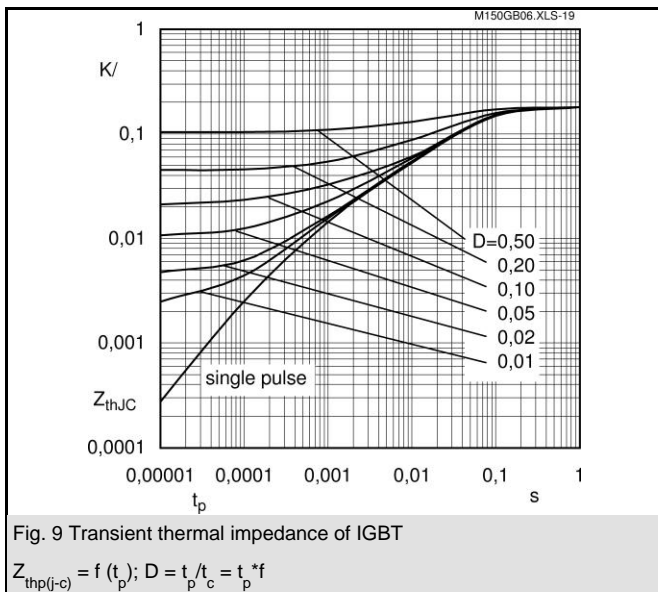
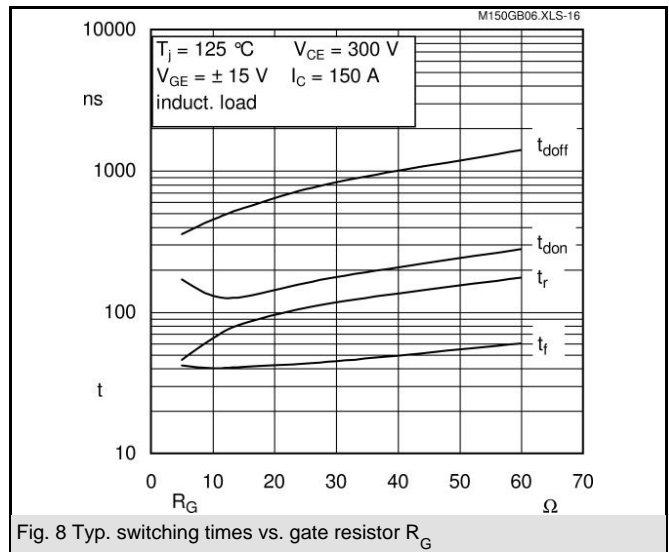
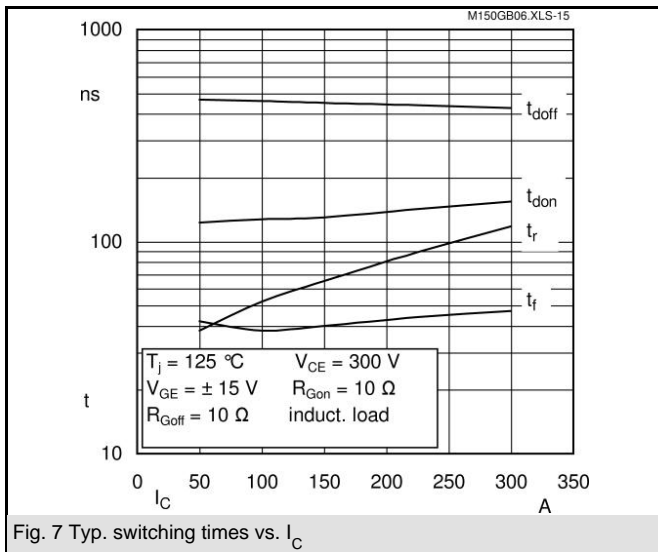


Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
<b>IGBT</b>			
$V_{CES}$		600	V
$I_C$	$T_c = 25 (70)^\circ\text{C}$	200 (150)	A
$I_{CRM}$	$t_p = 1 \text{ ms}$	300	A
$V_{GES}$		$\pm 20$	V
$T_{vj}$ ( $T_{stg}$ )	$T_{OPERATION} \leq T_{stg}$	-40 ... +150 (125)	$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	2500	V
<b>Inverse diode</b>			
$I_F$	$T_c = 25 (80)^\circ\text{C}$	130 (90)	A
$I_{FRM}$	$t_p = 1 \text{ ms}$	300	A
$I_{FSM}$	$t_p = 10 \text{ ms}$ ; sin.; $T_j = 150^\circ\text{C}$	880	A

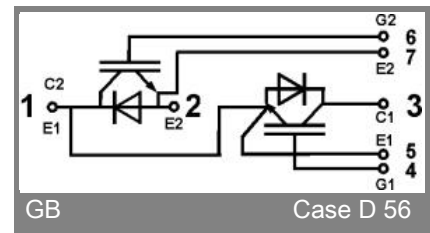
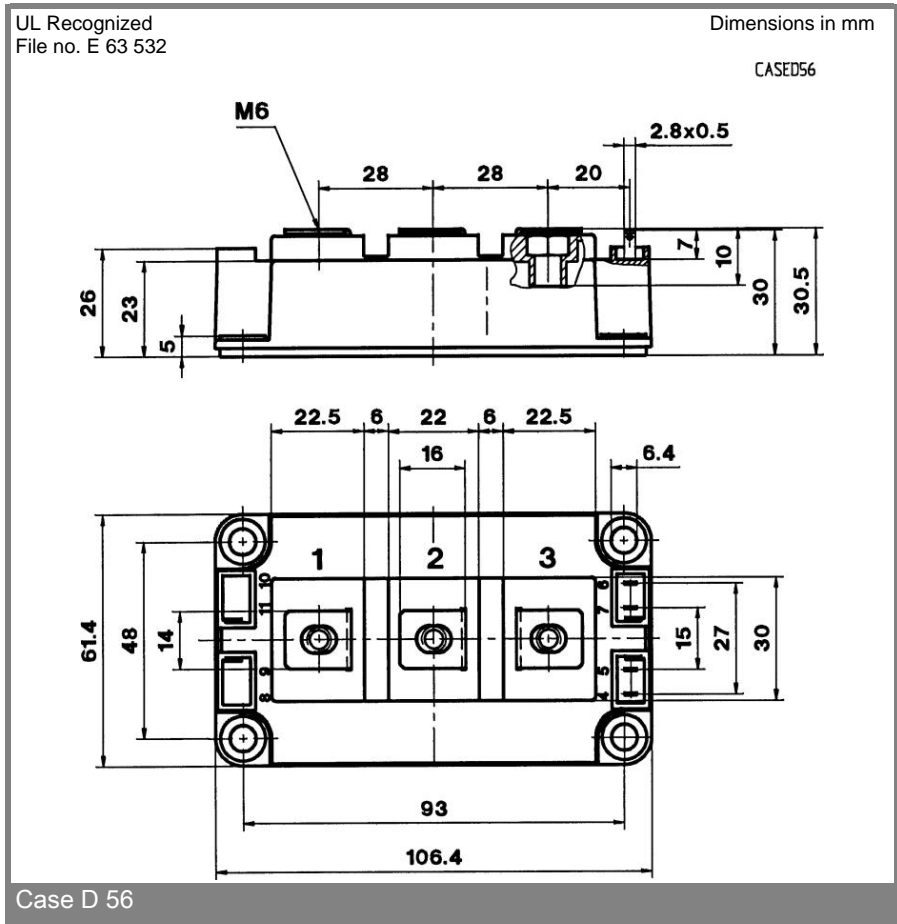
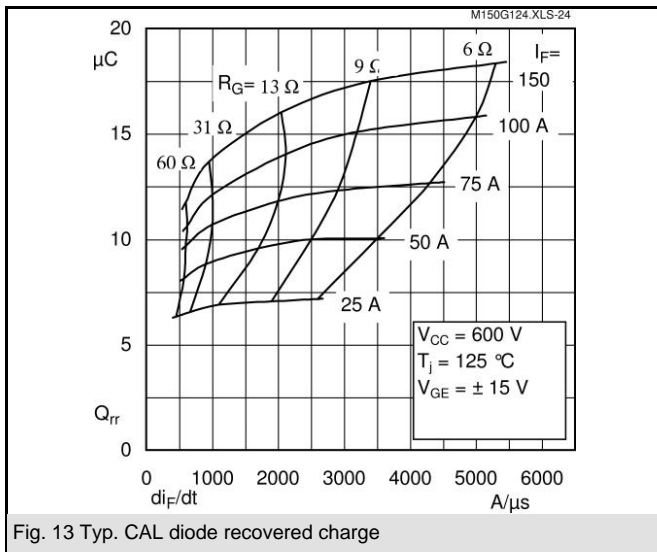
Characteristics		$T_c = 25^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 1 \text{ mA}$	4,5	5,5	6,5	V
$I_{CES}$	$V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25 (125)^\circ\text{C}$		0,15	0,45	mA
$V_{CE(TO)}$	$T_j = 25 (125)^\circ\text{C}$		1,05 (1)		V
$r_{CE}$	$V_{GE} = 15 \text{ V}$ , $T_j = 25 (125)^\circ\text{C}$		7 (8,7)		m $\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 150 \text{ A}$ , $V_{GE} = 15 \text{ V}$ , chip level		2,1 (2,4)	2,5 (2,8)	V
$C_{ies}$	under following conditions		8,4		nF
$C_{oes}$	$V_{GE} = 0$ , $V_{CE} = 25 \text{ V}$ , $f = 1 \text{ MHz}$		1		nF
$C_{res}$			0,6		nF
$L_{CE}$				20	nH
$R_{CC+EE'}$	res., terminal-chip $T_c = 25 (125)^\circ\text{C}$		0,35 (0,5)		m $\Omega$
$t_{d(on)}$	$V_{CC} = 300 \text{ V}$ , $I_{Cnom} = 150 \text{ A}$		130		ns
$t_r$	$R_{Gon} = R_{Goff} = 10 \Omega$ , $T_j = 125^\circ\text{C}$		65		ns
$t_{d(off)}$	$V_{GE} = \pm 15 \text{ V}$		450		ns
$t_f$			40		ns
$E_{on} (E_{off})$			8,5 (5,5)		mJ
<b>Inverse diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 150 \text{ A}$ ; $V_{GE} = 0 \text{ V}$ ; $T_j = 25 (125)^\circ\text{C}$		1,55 (1,55)	1,9	V
$V_{(TO)}$	$T_j = 125 ( )^\circ\text{C}$			0,9	V
$r_T$	$T_j = 125 ( )^\circ\text{C}$		6	8	m $\Omega$
$I_{RRM}$	$I_{Fnom} = 150 \text{ A}$ ; $T_j = 125 ( )^\circ\text{C}$		53		A
$Q_{rr}$	$di/dt = \text{A}/\mu\text{s}$		8,1		$\mu\text{C}$
$E_{rr}$	$V_{GE} = \text{V}$				mJ
<b>Thermal characteristics</b>					
$R_{th(j-c)}$	per IGBT			0,18	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,5	K/W
$R_{th(c-s)}$	per module			0,038	K/W
<b>Mechanical data</b>					
$M_s$	to heatsink M6	3		5	Nm
$M_t$	to terminals M6	2,5		5	Nm
w				325	g

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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.